Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination
09/978,082	PICHE ET AL.
Examiner	Art Unit
Alicia Baturay	2155

SEARCHED			
Class	Subclass	Date	Examiner
709	203	1/12/2005	АВ
709	231-233	9/6/2005	AB
370	229-236	9/6/2005	AB

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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		<u> </u>		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Requested PLUS Search	1/12/2005	AB
Conducted Inventor Name Search	1/12/2005	AB
Conducted searches on EAST	1/12/2005	AB
Searched ACM Digital Library	1/13/2005	АВ
Searched IEEE Xplore	1/13/2005	АВ
Consulted with Bharat Barot (AU 2155)	9/6/2005	AB
Updated Search	9/6/2005	АВ
Requested comprehensive STIC search	9/15/2006	АВ

Search Notes (continued)	Application/Control No.	Applicant(s)/l Reexamination
	09/978,082	PICHE ET A
	Examiner	Art Unit
(1361) X0 0 12 5 (3 1 1382) E 50 31 (6 6 X 121 121	Alicia Baturay	2155

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/978,082	PICHE ET AL.	
Examiner	Art Unit	
Alicia Baturay	2155	

SEARCHED			
Class	Subclass	Date	Examiner
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
	<u> </u>	<u> </u>	

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Updated Search	8/14/2006	AB
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